

BZT52H series

Single Zener diodes in a SOD123F package

Rev. 3 — 7 December 2010

Product data sheet

1. Product profile

1.1 General description

General-purpose Zener diodes in a SOD123F small and flat lead Surface-Mounted Device (SMD) plastic package.

1.2 Features and benefits

- Total power dissipation: ≤ 830 mW
- Wide working voltage range: nominal 2.4 V to 75 V (E24 range)
- Small plastic package suitable for surface-mounted design
- Low differential resistance
- AEC-Q101 qualified

1.3 Applications

General regulation functions

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{F}	forward voltage	$I_F = 10 \text{ mA}$	<u>[1]</u> _	-	0.9	V
P _{tot}	total power dissipation	$T_{amb} \le 25 ^{\circ}C$	[2] _	-	375	mW
			[3] _	-	830	mW

^[1] Pulse test: $t_p \le 300~\mu s;~\delta \le 0.02.$

2. Pinning information

Table 2. Pinning

Pin	Description	Simplified outline	Graphic symbol
1	cathode	[1]	
2	anode	1 2	1 2 006aaa152

^[1] The marking bar indicates the cathode.



^[2] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.

^[3] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for cathode 1 cm².

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BZT52H-B2V4 to BZT52H-C75[1]	-	plastic surface-mounted package; 2 leads	SOD123F

^[1] The series consists of 74 types with nominal working voltages from 2.4 V to 75 V.

4. Marking

Table 4. Marking codes

Type number	Marking code	Type number	Marking code	Type number	Marking code	Type number	Marking code
BZT52H-B2V4	DC	BZT52H-B15	DX	BZT52H-C2V4	B3	BZT52H-C15	BN
BZT52H-B2V7	DD	BZT52H-B16	DY	BZT52H-C2V7	B4	BZT52H-C16	BP
BZT52H-B3V0	DE	BZT52H-B18	DZ	BZT52H-C3V0	B5	BZT52H-C18	BQ
BZT52H-B3V3	DF	BZT52H-B20	E1	BZT52H-C3V3	B6	BZT52H-C20	BR
BZT52H-B3V6	DG	BZT52H-B22	E2	BZT52H-C3V6	B7	BZT52H-C22	BS
BZT52H-B3V9	DH	BZT52H-B24	E3	BZT52H-C3V9	B8	BZT52H-C24	BT
BZT52H-B4V3	DJ	BZT52H-B27	E4	BZT52H-C4V3	В9	BZT52H-C27	BU
BZT52H-B4V7	DK	BZT52H-B30	E5	BZT52H-C4V7	BA	BZT52H-C30	BV
BZT52H-B5V1	DL	BZT52H-B33	E6	BZT52H-C5V1	BB	BZT52H-C33	BW
BZT52H-B5V6	DM	BZT52H-B36	E7	BZT52H-C5V6	ВС	BZT52H-C36	ВХ
BZT52H-B6V2	DN	BZT52H-B39	E8	BZT52H-C6V2	BD	BZT52H-C39	BY
BZT52H-B6V8	DP	BZT52H-B43	E9	BZT52H-C6V8	BE	BZT52H-C43	BZ
BZT52H-B7V5	DQ	BZT52H-B47	EA	BZT52H-C7V5	BF	BZT52H-C47	C1
BZT52H-B8V2	DR	BZT52H-B51	EB	BZT52H-C8V2	BG	BZT52H-C51	C2
BZT52H-B9V1	DS	BZT52H-B56	EC	BZT52H-C9V1	ВН	BZT52H-C56	C3
BZT52H-B10	DT	BZT52H-B62	ED	BZT52H-C10	BJ	BZT52H-C62	C4
BZT52H-B11	DU	BZT52H-B68	EE	BZT52H-C11	BK	BZT52H-C68	C5
BZT52H-B12	DV	BZT52H-B75	EF	BZT52H-C12	BL	BZT52H-C75	C6
BZT52H-B13	DW	-	-	BZT52H-C13	BM	-	-

5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
I _F	forward current			-	250	mA
I _{ZSM}	non-repetitive peak reverse current			-	see <u>Table 8, 9</u> and <u>10</u>	
P _{ZSM}	non-repetitive peak reverse power dissipation		[1]	-	40	W
P _{tot}	total power dissipation	$T_{amb} \le 25 ^{\circ}C$	[2]	-	375	mW
			[3]	-	830	mW
Tj	junction temperature			-	150	°C
T _{amb}	ambient temperature			-65	+150	°C
T _{stg}	storage temperature			-65	+150	°C

^[1] $t_p = 100 \mu s$; square wave; $T_j = 25 \,^{\circ}C$ prior to surge.

6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
R _{th(j-a)}	thermal resistance from	in free air	[1]	-	-	330	K/W
	junction to ambient		[2]	-	-	150	K/W
$R_{th(j-sp)}$	thermal resistance from junction to solder point		[3]	-	-	70	K/W

^[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

^[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

^[3] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for cathode 1 cm².

^[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for cathode 1 cm².

^[3] Soldering point of cathode tab.

7. Characteristics

Table 7. Characteristics

 $T_i = 25$ °C unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{F}	forward voltage	$I_F = 10 \text{ mA}$	<u>[1]</u> -	-	0.9	V

^[1] Pulse test: $t_p \le 300~\mu s;~\delta \le 0.02.$

Table 8. Characteristics per type; BZT52H-B2V4 to BZT52H-C24

 $T_i = 25$ °C unless otherwise specified.

BZT52H Sel -xxx				voltage resistance $r_{dif}(\Omega)$			current I _R (μA)		erature cient //K); mA	Diode capacitance C _d (pF) ^[1]	Non-repetitive peak reverse current I _{ZSM} (A)[2]
		Min	Max	I _Z = 1 mA	I _Z = 5 mA	Max	V _R (V)	Min	Max	Max	Max
2V4	В	2.35	2.45	400	85	50	1	-3.5	0.0	450	6.0
	С	2.2	2.6								
2V7	В	2.65	2.75	500	83	20	1	-3.5	0.0	450	6.0
	С	2.5	2.9								
3V0	В	2.94	3.06	500	95	10	1	-3.5	0.0	450	6.0
	С	2.8	3.2								
3V3	В	3.23	3.37	500	95	5	1	-3.5	0.0	450	6.0
	С	3.1	3.5								
3V6	В	3.53	3.67	500	95	5	1	-3.5	0.0	450	6.0
	С	3.4	3.8								
3V9	В	3.82	3.98	500	95	3	1	-3.5	0.0	450	6.0
	С	3.7	4.1								
4V3	В	4.21	4.39	500	95	3	1	-3.5	0.0	450	6.0
	С	4.0	4.6								
4V7	В	4.61	4.79	500	78	3	2	-3.5	0.2	300	6.0
	С	4.4	5.0								
5V1	В	5.0	5.2	480	60	2	2	-2.7	1.2	300	6.0
	С	4.8	5.4								
5V6	В	5.49	5.71	400	40	1	2	-2.0	2.5	300	6.0
	С	5.2	6.0								
6V2	В	6.08	6.32	150	10	3	4	0.4	3.7	200	6.0
	С	5.8	6.6								
6V8	В	6.66	6.94	80	8	2	4	1.2	4.5	200	6.0
	С	6.4	7.2								
7V5	В	7.35	7.65	80	10	1	5	2.5	5.3	150	4.0
	С	7.0	7.9								
8V2	В	8.04	8.36	80	10	0.7	5	3.2	6.2	150	4.0
	С	7.7	8.7								

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Table 8. Characteristics per type; BZT52H-B2V4 to BZT52H-C24 ...continued $T_i = 25$ °C unless otherwise specified.

BZT52H -xxx			je ;	resistance r_{dif} (Ω)		Revers	se t I _R (μΑ)	Tempe coeffic S _Z (m\ I _Z = 5 i	//K);	Diode capacitance C _d (pF)[1]	Non-repetitive peak reverse current I _{ZSM} (A)[2]
		Min	Max	I _Z = 1 mA	I _Z = 5 mA	Max	V _R (V)	Min	Max	Max	Max
9V1	В	8.92	9.28	100	10	0.5	6	3.8	7.0	150	3.0
	С	8.5	9.6								
10	В	9.8	10.2	70	10	0.2	7	4.5	8.0	90	3.0
	С	9.4	10.6								
11	В	10.8	11.2	70	10	0.1	8	5.4	9.0	85	2.5
	С	10.4	11.6								
12	В	11.8	12.2	90	10	0.1	8	6.0	10.0	85	2.5
	С	11.4	12.7								
13	В	12.7	13.3	110	10	0.1	8	7.0	11.0	80	2.5
	С	12.4	14.1								
15	В	14.7	15.3	110	15	0.05	10.5	9.2	13.0	75	2.0
	С	13.8	15.6								
16	В	15.7	16.3	170	20	0.05	11.2	10.4	14.0	75	1.5
	С	15.3	17.1								
18	В	17.6	18.4	170	20	0.05	12.6	12.4	16.0	70	1.5
	С	16.8	19.1								
20	В	19.6	20.4	220	20	0.05	14	14.4	18.0	60	1.5
	С	18.8	21.2								
22	В	21.6	22.4	220	25	0.05	15.4	16.4	20.0	60	1.25
	С	20.8	23.3								
24	В	23.5	24.5	220	30	0.05	16.8	18.4	22.0	55	1.25
	С	22.8	25.6								

^[1] f = 1 MHz; $V_R = 0 \text{ V}$.

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^[2] $t_p = 100 \ \mu s$; $T_{amb} = 25 \ ^{\circ}C$.

Table 9. Characteristics per type; BZT52H-B27 to BZT52H-C51

 $T_i = 25$ °C unless otherwise specified.

BZT52H -xxx	Sel	Worki voltag V _Z (V) I _Z = 2	je ;	Maximum (resistance		Revers	e t I _R (μΑ)	Tempe coeffic S _Z (m\ I _Z = 5 r	//K);	Diode capacitance C _d (pF)[1]	Non-repetitive peak reverse current I _{ZSM} (A)[2]
		Min	Max	I _Z = 1 mA	I _Z = 5 mA	Max	V _R (V)	Min	Max	Max	Max
27	В	26.5	27.5	250	40	0.05	18.9	21.4	25.3	50	1.0
	С	25.1	28.9								
30	В	29.4	30.6	250	40	0.05	21	24.4	29.4	50	1.0
	С	28.0	32.0								
33	В	32.3	33.7	250	40	0.05	23.1	27.4	33.4	45	0.9
	С	31.0	35.0								
36	В	35.3	36.7	250	60	0.05	25.2	30.4	37.4	45	0.8
	С	34.0	38.0								
39	В	38.2	39.8	300	75	0.05	27.3	33.4	41.2	45	0.7
	С	37.0	41.0								
43	В	42.1	43.9	325	80	0.05	30.1	37.6	46.6	40	0.6
	С	40.0	46.0								
47	В	46.1	47.9	325	90	0.05	32.9	42.0	51.8	40	0.5
	С	44.0	50.0								
51	В	50.0	52.0	350	100	0.05	35.7	46.6	57.2	40	0.4
	С	48.0	54.0								

^[1] f = 1 MHz; $V_R = 0 \text{ V}$.

Table 10. Characteristics per type; BZT52H-B56 to BZT52H-C75

 $T_i = 25$ °C unless otherwise specified.

BZT52H Sel -xxx		- 3					current I _R (μA)		rature ient //K); nA	Diode capacitance C _d (pF)[1]	Non-repetitive peak reverse current I _{ZSM} (A)[2]
		Min	Max	$I_Z = 0.5 \text{ mA}$	I _Z = 2 mA	Max	V _R (V)	Min	Max	Max	Max
56	В	54.9	57.1	375	120	0.05	39.2	52.2	63.8	40	0.3
	С	52.0	60.0								
62	В	60.8	63.2	400	140	0.05	43.4	58.8	71.6	35	0.3
	С	58.0	66.0								
68	В	66.6	69.4	400	160	0.05	47.6	65.6	79.8	35	0.25
	С	64.0	72.0								
75	В	73.5	76.5	400	175	0.05	52.5	73.4	88.6	35	0.20
	С	70.0	79.0								

^[1] f = 1 MHz; $V_R = 0 \text{ V}$.

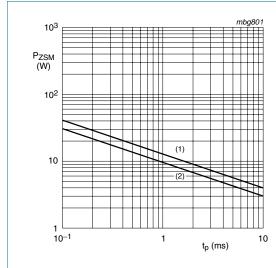
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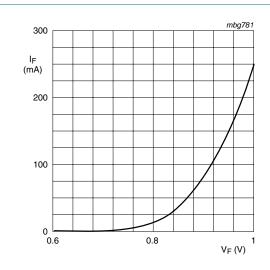
^[2] $t_p = 100 \ \mu s; T_{amb} = 25 \ ^{\circ}C.$

^[2] $t_p = 100 \ \mu s; T_{amb} = 25 \ ^{\circ}C.$



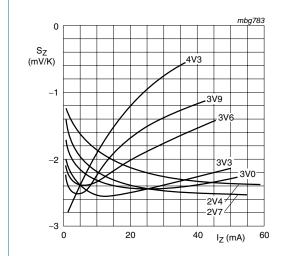
- (1) $T_j = 25 \,^{\circ}\text{C}$ (prior to surge)
- (2) $T_i = 150$ °C (prior to surge)

Fig 1. Non-repetitive peak reverse power dissipation as a function of pulse duration; maximum values



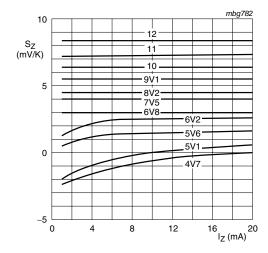
T_j = 25 °C

Fig 2. Forward current as a function of forward voltage; typical values



BZT52H-B/C2V4 to BZT52H-B/C4V3 $T_i = 25$ °C to 150 °C

Fig 3. Temperature coefficient as a function of working current; typical values



BZT52H-B/C4V7 to BZT52H-B/C12

 $T_j = 25 \, ^{\circ}\text{C}$ to 150 $^{\circ}\text{C}$

Fig 4. Temperature coefficient as a function of working current; typical values

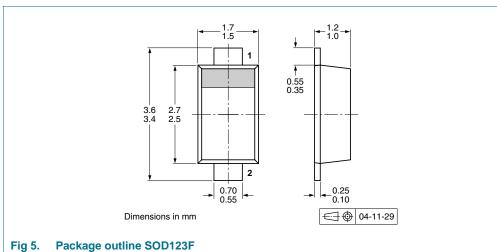
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8. Test information

8.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard *Q101 - Stress test qualification for discrete semiconductors*, and is suitable for use in automotive applications.

9. Package outline



1 ig 3. Tackage outline 30D12

10. Packing information

Table 11. Packing methods

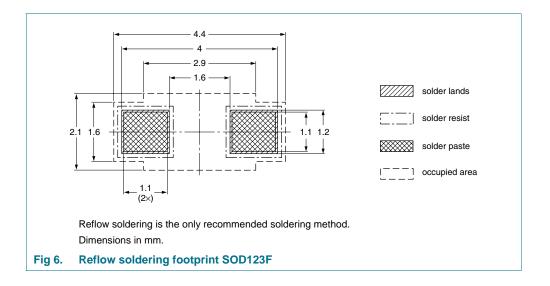
The indicated -xxx are the last three digits of the 12NC ordering code.[1]

Type number	Package	Description	Packing quantity		
			3000	10000	
BZT52H-B2V4 to BZT52H-C75	SOD123F	4 mm pitch, 8 mm tape and reel	-115	-135	

[1] For further information and the availability of packing methods, see Section 14.

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11. Soldering



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12. Revision history

Table 12. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes	
BZT52H_SER v.3	20101207	Product data sheet	-	BZT52H_SER v.2	
Modifications:	Added selection B.				
	 Section 1.2 "Features and benefits": amended. 				
	 <u>Table 2 "Pinning"</u>: graphic symbol updated. 				
	 Section 8 "Test information": added. 				
 <u>Section 13 "Legal information"</u>: updated. 					
BZT52H_SER v.2	20091115	Product data sheet	-	BZT52H_SER v.1	
BZT52H_SER v.1	20051222	Product data sheet	-	-	

13. Legal information

13.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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BZT52H series

Single Zener diodes in a SOD123F package

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BZT52H series

Single Zener diodes in a SOD123F package

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